

**Search Notes**

Application/Control No.

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Examiner

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Applicant(s)/Patent under  
Reexamination

YOUN, JEONGNAM

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
updated	search	4/4/2007	MAI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUB text search (see UPDATED interference search printout)		4/4/2007	MAI

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search (see printout)	4/4/2007	MAI